

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination RUEHLE ET AL.	
		Examiner Kim Huynh	Art Unit 2182	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,061,449	05-2000	Candelore et al.	380/28
	B	US-4,627,074	12-1986	Markwitz et al.	380/267
	C	US-5,377,264	12-1994	Lee et al.	713/189
	D	US-5,249,232	09-1993	Erbes et al.	713/190
	E	US-6,092,193	07-2000	Loomis et al.	713/193
	F	US-5,408,678	04-1995	Kato et al.	710/60
	G	US-4,060,797	11-1977	Maxwell et al.	341/106
	H	US-3,629,847	12-1971	Adlhoch, Richard H.	340/825.26
	I	US-5,392,316	02-1995	Sawaguchi et al.	375/290
	J	US-5,491,698	02-1996	Patel et al.	714/709
	K	US-6,522,694	02-2003	Ryan, Robert T.	375/240.25
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.